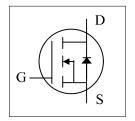


- **▼** Simple Drive Requirement
- **▼** Good Thermal Dissipation
- **▼** Low On-resistance
- **▼** RoHS Compliant & Halogen-Free



BV <sub>DSS</sub>	30V
R <sub>DS(ON)</sub>	$\operatorname{9m}\Omega$
$I_D$	16A

# **Description**

Advanced Power MOSFETs from AP provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The PMPAK <sup>®</sup> 3 x 3 package is special for DC-DC converters application and lower 1.0mm profile with backside heat sink.



# Absolute Maximum Ratings@T=25°C(unless otherwise specified)

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	30	V
$V_{GS}$	Gate-Source Voltage	<u>+</u> 20	V
I <sub>D</sub> @T <sub>A</sub> =25°C	Drain Current <sup>3</sup> , V <sub>GS</sub> @ 10V	16	Α
I <sub>D</sub> @T <sub>A</sub> =70°C	Drain Current <sup>3</sup> , V <sub>GS</sub> @ 10V	13	Α
I <sub>DM</sub>	Pulsed Drain Current <sup>1</sup>	40	Α
P <sub>D</sub> @T <sub>A</sub> =25°€	Total Power Dissipation	3.5	W
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	$^{\circ}\mathbb{C}$
$T_J$	Operating Junction Temperature Range	-55 to 150	$^{\circ}\!\mathbb{C}$

### **Thermal Data**

Symbol	Parameter	Value	Units	
Rthj-a	Maximum Thermal Resistance, Junction-ambient <sup>3</sup>	35	°C/W	

# Electrical Characteristics@T<sub>j</sub>=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250uA	30	-	-	V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =10A	ı	ı	9	$\mathbf{m}\Omega$
		$V_{GS}$ =4.5V, $I_D$ =8A	ı	ı	16	$\mathbf{m}\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250uA	1	ı	3	V
g <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =10V, I <sub>D</sub> =10A	ı	24	-	S
I <sub>DSS</sub>	Drain-Source Leakage Current	$V_{DS}$ =30V, $V_{GS}$ =0V	-		10	uA
	Drain-Source Leakage Current (T <sub>j</sub> =70°C)	$V_{DS}$ =24V, $V_{GS}$ =0V	-	1	250	uA
$I_{GSS}$	Gate-Source Leakage	V <sub>GS</sub> = <u>+</u> 20V, V <sub>DS</sub> =0V	1		<u>+</u> 100	nΑ
$Q_g$	Total Gate Charge <sup>2</sup>	I <sub>D</sub> =10A		8.7	14	nC
$Q_{gs}$	Gate-Source Charge	V <sub>DS</sub> =15V	1	1.7		nC
$Q_{gd}$	Gate-Drain ("Miller") Charge	V <sub>GS</sub> =4.5V		5	-	nC
t <sub>d(on)</sub>	Turn-on Delay Time <sup>2</sup>	V <sub>DS</sub> =15V	-	10	-	ns
t <sub>r</sub>	Rise Time	I <sub>D</sub> =1A	-	7	-	ns
$t_{d(off)}$	Turn-off Delay Time	$R_G=6\Omega$		24	_	ns
t <sub>f</sub>	Fall Time	V <sub>GS</sub> =10V	-	8	-	ns
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V	-	635	1010	pF
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =25V	-	215	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	f=1.0MHz	-	125	-	pF
$R_g$	Gate Resistance	f=1.0MHz		1.8		Ω

## Source-Drain Diode

Symb	ol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
V <sub>SD</sub>		Forward On Voltage <sup>2</sup>	I <sub>S</sub> =2.9A, V <sub>GS</sub> =0V	1	ı	1.2	V
t <sub>rr</sub>		Reverse Recovery Time <sup>2</sup>	I <sub>S</sub> =10A, V <sub>GS</sub> =0V,	-	27	ı	ns
Q <sub>rr</sub>		Reverse Recovery Charge	dl/dt=100A/µs	-	20	-	nC

#### Notes:

- 1. Pulse width limited by Max. junction temperature.
- 2 Pulse test
- 3.Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board, t ≤10sec

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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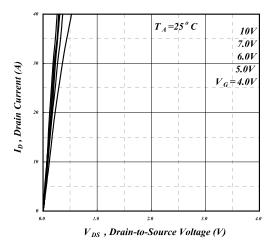


Fig 1. Typical Output Characteristics

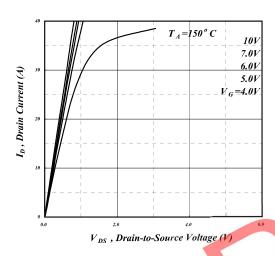


Fig 2. Typical Output Characteristics

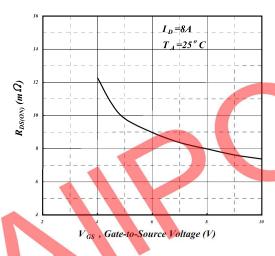


Fig 3. On-Resistance v.s. Gate Voltage

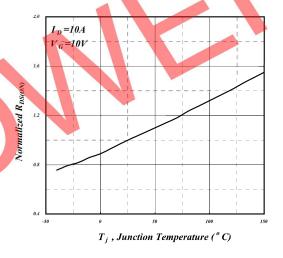


Fig 4. Normalized On-Resistance v.s. Junction Temperature

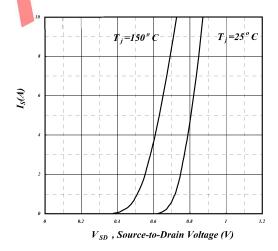


Fig 5. Forward Characteristic of Reverse Diode

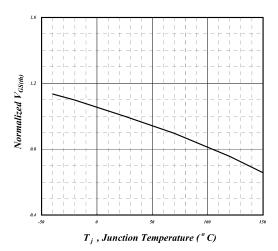


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

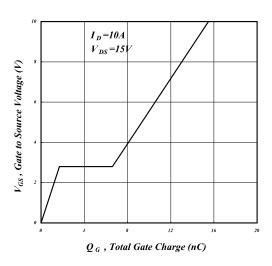


Fig 7. Gate Charge Characteristics

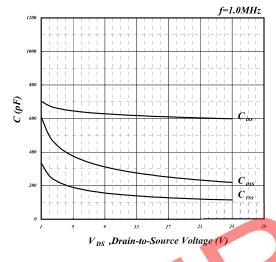


Fig 8. Typical Capacitance Characteristics

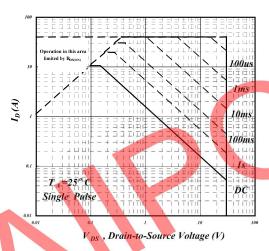


Fig 9. Maximum Safe Operating Area

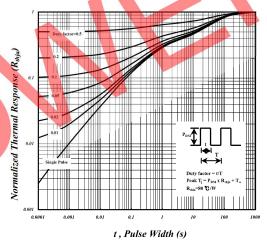


Fig 10. Effective Transient Thermal Impedance

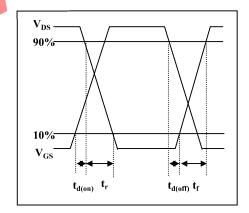


Fig 11. Switching Time Waveform

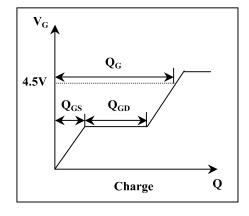


Fig 12. Gate Charge Waveform

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